

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No. 10/516,927
Filing Date December 1, 2004
Inventorship Lay Har Angeline Tee et al.
Assignee SENSFAB PTE LTD
Group Art Unit 1763
Examiner Unknown
Attorney's Docket No. DR10-006
Title: Method of Forming Atomic Force Microscope Tips

INFORMATION DISCLOSURE STATEMENT

References - See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. Copies of the U.S. cited art are not included (1276 Off. Gaz. Pat. Off 55, 05 August 2003). No admission is made regarding whether all the submitted references are prior art.

This Information Disclosure Statement is being filed within three months of the filing date of the application or before the mailing of a first Office Action on the merits, whichever occurs last. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

Dated: May 20, 2005

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Form PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF ART CITED BY APPLICANT
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DR10-006 SERIAL NO.
10/516,927APPLICANT
Lay Har Angeline Tee et al.FILING DATE
December 1, 2004 GROUP
1763

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	4,943,719	07-1990	Akamine et al.			
	AB	5,336,369	08-1994	Kado et al.			
	AC	5,614,663	03-1997	Itoh et al.			
	AD	5,965,218	10-1999	Bothra et al.			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Sub-class	Translation	
							Yes	No
	AK	JP2001-21478	01-2001	Japan				x
	AL	WO 01/06516 A1	01-2001	PCT				
	AM							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

	AN	
	AO	
	AP	
EXAMINER	DATE CONSIDERED	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.